

## RECEIVED FEB 1 1 2003 TC 1700

**PATENT** 

715 +3/2

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In Re U.S. Patent Application

Applicant: Kozo Nakamura, et al.

Serial No.: 09/856,212

Filed:

For:

May 18, 2001

Way 16, 2001

And Production Device For Single Crystal )
Ingot, And Heat Treating Method For Silicon )

Production Method For Silicon Single Crystal)

Single Crystal Water

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Examiner: Matthew J. Song

) Group Art Unit: 1765

) I hereby certify that this correspondence
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) Commissioner of Patents. Washington, DC

) 20231, on February 4, 2003.

Gerald T. Shekleton Rev. No. 27 466. Date

AMENDMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

The Office Action of November 5, 2002 has been carefully reviewed and the following amendments/remarks are made in response thereto.

IN THE CLAIMS

Please amend Claims 1-5, 7 and 9-11 as follows:

(Amended) A method for producing a relatively defect free silicon single crystal ingot under the following conditions:

Entered WRCE 3/11/03